

Notice of References Cited

Application/Control No.

09/303,587

Applicant(s)/Patent Under
Reexamination
VILJANMAA ET AL.

Examiner

Louis K. Huynh

Art Unit

3721

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*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
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	B	US-4,625,637-B1	12-1986	Pav et al.	100	162B
	C	US-4,644,860-B1	02-1987	Brendel	100	162B
	D	US-4,903,517-B1	02-1990	Van Haag et al.	100	162B
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		Country Code-Number-Kind Code	MM-YYYY				
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	T	- -					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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